

# A bulge test based methodology for characterizing ultra-thin buckled membranes

### Citation for published version (APA):

Shafqat, S., van der Sluis, O., Geers, M. G. D., & Hoefnagels, J. P. M. (2018). A bulge test based methodology for characterizing ultra-thin buckled membranes. Thin Solid Films, 660, 88-100. https://doi.org/10.1016/j.tsf.2018.04.005

Document license: CC BY

DOI: 10.1016/j.tsf.2018.04.005

### Document status and date:

Published: 09/04/2018

#### Document Version:

Accepted manuscript including changes made at the peer-review stage

#### Please check the document version of this publication:

• A submitted manuscript is the version of the article upon submission and before peer-review. There can be important differences between the submitted version and the official published version of record. People interested in the research are advised to contact the author for the final version of the publication, or visit the DOI to the publisher's website.

• The final author version and the galley proof are versions of the publication after peer review.

• The final published version features the final layout of the paper including the volume, issue and page numbers.

Link to publication

#### General rights

Copyright and moral rights for the publications made accessible in the public portal are retained by the authors and/or other copyright owners and it is a condition of accessing publications that users recognise and abide by the legal requirements associated with these rights.

- · Users may download and print one copy of any publication from the public portal for the purpose of private study or research.
- You may not further distribute the material or use it for any profit-making activity or commercial gain
  You may freely distribute the URL identifying the publication in the public portal.

If the publication is distributed under the terms of Article 25fa of the Dutch Copyright Act, indicated by the "Taverne" license above, please follow below link for the End User Agreement:

www.tue.nl/taverne

#### Take down policy

If you believe that this document breaches copyright please contact us at:

openaccess@tue.nl

providing details and we will investigate your claim.

1	A burge test based methodology
2	for characterizing ultra-thin buckled membranes
3	Salman Shafqat <sup>1</sup> , Olaf van der Sluis <sup>1, 2</sup> , Marc Geers <sup>1</sup> , and Johan Hoefnagels <sup>1, †</sup>
4	<sup>1</sup> Department of Mechanical Engineering, Eindhoven University of Technology, 5600 MB
5	Eindhoven, the Netherlands;
6	<u>s.shafqat@tue.nl; o.v.d.sluis@tue.nl; m.g.d.geers@tue.nl; j.p.m.hoefnagels@tue.nl</u>
7	<sup>2</sup> Philips Research, High Tech Campus 4, 5654 AE Eindhoven, the Netherlands
8	<sup>+</sup> Corresponding author: <a href="mailto:j.p.m.hoefnagels@tue.nl">j.p.m.hoefnagels@tue.nl</a> ; Tel.: +31-40-2475894
9	

# 10 Abstract

11 Buckled membranes become ever more important with further miniaturization and development 12 of ultra-thin film based systems. It is well established that the bulge test method, generally 13 considered the gold standard for characterizing freestanding thin films, is unsuited to characterize 14 buckled membranes, because of compressive residual stresses and a negligible out-of-plane 15 bending stiffness. When pressurized, buckled membranes immediately start entering the ripple 16 regime, but they typically plastically deform or fracture before reaching the cylindrical regime. In 17 this paper the bulge test method is extended to enable characterization of buckled freestanding 18 ultra-thin membranes in the ripple regime. In a combined experimental-numerical approach, the advanced technique of digital height correlation was first extended towards the sub-micron scale, 19

20 to enable measurement of the highly varying local 3D strain and curvature fields on top of a single 21 ripple in a total region of interest as small as ~25 μm. Subsequently, a finite element (FE) model 22 was set up to analyze the post-buckled membrane under pressure loading. In the seemingly 23 complex ripple configuration, a suitable combination of local region of interest and pressure 24 range was identified for which the stress-strain state can be extracted from the local strain and 25 curvature fields. This enables the extraction of both the Young's modulus and Poisson's ratio from 26 a single bulge sample, contrary to the conventional bulge test method. Virtual experiments 27 demonstrate the feasibility of the approach, while real proof of principle of the method was 28 demonstrated for fragile specimens with rather narrow (~25 µm) ripples.

Keywords: Bulge Test Method; Buckled Membrane; Wrinkled Membrane, Ultra-thin Films,
 Freestanding Films; Digital Image Correlation (DIC); Digital Height Correlation (DHC); Global Digital
 Image Correlation (GDIC)

# 32 1. Introduction

33 The bulge test methodology has become the standard technique for mechanical characterization 34 of thin films [1] especially for freestanding membranes. This is due to (1) the possibility of precise 35 sample processing facilitated by recent developments in micro-fabrication technology; (2) the 36 need for minimal sample handling, which is especially challenging at small scales; (3) the relatively 37 simple data processing for determining the membrane stress and strain values, needed to extract 38 the mechanical properties. The method essentially involves fixing a freestanding membrane over 39 a small window opening and applying a known pressure to it, while measuring the resulting 40 membrane deflection (or curvature). Various models have been developed, based on the sample 41 geometry, to convert the pressure-deflection data to the a (elasto-plastic) stress-strain curve, 42 which is used to determine mechanical properties such as Young's modulus, Poisson's ratio, 43 residual stresses, and plasticity parameters [1-3]. During the last 30 years ample research has 44 been devoted to improve the accuracy of the bulge test by studying the underlying assumptions 45 such as the influence of bending stiffness [4] and initial conditions e.g. initial film thickness and 46 residual stress [1,5,6]. Among the different varieties of the bulge test method, the plane-strain 47 bulge test is most popular [7], where it was shown that for rectangular membranes with in-plane 48 aspect ratio larger than 4, the stress state in the center of the membrane reduces to a plane strain condition. This means that the stress and the strain are given by [4]: 49

$$\kappa_{tt} = \frac{2\delta}{a^2 + \delta^2},\tag{1}$$

$$\sigma_{tt} = \frac{P}{h \kappa_{tt}},\tag{2}$$

$$\epsilon_{tt} = \frac{1}{a\kappa_{tt}} \sin^{-1}(a\kappa_{tt}) - 1, \tag{3}$$

50 where  $\kappa_{tt}$  is the curvature in the transverse direction, *a* is half of the width of the membrane,  $\delta$ 51 is the deflection of the apex of the membrane, *P* is the applied pressure and *h* is the membrane 52 thickness.  $\sigma_{tt}$  and  $\epsilon_{tt}$  denote the normal stress and strain in the transverse direction, respectively. 53 As a consequence of the plane strain condition in the center of the rectangular membrane, the 54 transverse stress and the transverse strain can be related by the following constitutive equation:

$$\sigma_{tt} = \left(\frac{E}{1-\nu^2}\right)\epsilon_{tt},\tag{4}$$

where  $\left(\frac{E}{1-\nu^2}\right)$  is the plane strain modulus. To extract the Young's modulus (*E*) and the Poisson's ratio ( $\nu$ ) separately, an additional test needs to be performed, e.g., a bulge test on a circular or 57 square membrane for which a different stress-strain equation holds, resulting in the biaxial 58 modulus  $\left(\frac{E}{1-\nu}\right)$  [2,8].

59 However, such freestanding membranes often buckle as a result of processing induced 60 (compressive) residual stresses in combination with their small out-of-plane bending stiffness, 61 particularly for ultra-thin membranes. In some cases, the buckling is exploited as a functional part in devices, e.g., in bi-stable micro actuators [9-11]. Moreover, the buckling phenomenon in 62 63 freestanding thin membranes has gained a lot of attention in Micro Solid Oxide Fuel Cells (µSOFC), 64 where stacks of freestanding membranes serving as electrodes or solid electrolytes, are often 65 buckled as a result of the processing. While initially buckling was considered an issue [12], recent 66 literature suggests that it can actually be beneficial to have these membranes in a buckled state to enhance their functional properties. It has been shown that buckled membranes are 67 68 mechanically more stable at elevated temperatures, i.e. lower thermomechanical tensile stresses 69 develop compared to a 'flat' membrane, often having significant tensile stresses already at room 70 temperature [13], [14]. Mechanical models have been developed to exploit the behavior of such 71 µSOFC membranes in the post-buckling regime and consequently expand the design space into 72 the low-stress post-buckling regime [12,13]. Recently, controlled buckling patterns in µSOFC solid 73 electrolyte membranes (Figure 1a) using 'strain engineering' have been employed to demonstrate 74 local tuning of ionic conductivity of the electrolyte as an alternative of solid solution doping [15]. 75 Furthermore, in the exciting field of graphene, where buckles and ripples are intrinsically present 76 in the suspended configuration (Figure 1b), these phenomena are receiving considerable 77 attention [16] to be exploited in various applications [17], such as improved hydrogen absorption

- on a rippled graphene surface (due to local curvature), for future efficient hydrogen-based fuel
- 79 cells [18].



Figure 1: Examples of applications of buckled membranes: (a) design and placement of electrodes to locally
strain-engineered ionic transport of the solid electrolyte freestanding membrane for µSOFC application [15]
(reproduced with permission), (b) SEM micrograph showing ripples in a bilayer suspended graphene
membrane [16] (reproduced with permission).

86

81

87 The presence of such buckling patterns in test samples, as shown in Figure 2, prevents the application of the conventional bulge test. All available literature to date confirms that the 88 89 conventional bulge test methodology cannot be used to characterize buckled membranes since 90 even at high pressures, buckling patterns typically do not disappear in the membranes and some 91 stress components near the edge of the membrane stay compressive [2,19]. Only in very few 92 cases, the samples can be pressurized, beyond the point where the buckling pattern completely 93 disappears, where the bulge equations (1)-(4) might apply [2,19]. Alternatively, the sample may 94 deform plastically before entering the cylindrical regime. Therefore, such buckled samples are typically discarded and the processing needs to be modified to prevent the buckles to occur, in
order to mechanically characterize the membranes accurately. Such processing modifications can
be time consuming, costly and sometimes even infeasible or undesired. Moreover, any processing
change could influence the actual properties to be determined.

99



100

Figure 2: (Top) Typical 'flat' freestanding bulge test membrane. (Bottom) Buckled membrane
 meandering/telephone cord type pattern [19] (reproduced with permission).

103

104 Clearly there is a need for a convenient characterization methodology to determine the material105 properties of the buckled samples in their original (buckled) state.

This paper introduces a characterization methodology for testing buckled samples, which builds on the bulge test theory and thus exploits its aforementioned advantages. The approach adopted here is to numerically model the bulge test-like pressure loading of the buckled membrane in the rippled regime, to which the meandering pattern (see Figure 2 bottom) starts transitioning as soon as even minute pressure is applied [20], to understand the mechanics and provide relations for the relevant membrane stress and strain components. To relate the stresses and strains using simple constitutive equations for extracting the material properties, regions of interest (ROI) with simplified stress states are identified and explored. Furthermore, to accurately measure the complex non-uniform three-dimensional displacement field of the buckled membranes, recent advances in bulge test methodology involving integration of Global Digital Image Correlation (GDIC) with conventional bulge test theory to [8] are exploited.

### 117 2. Methodology

### 118 2.1 Digital height correlation based bulge test

119 In conventional bulge test theory, the stresses and the strains obtained using equation (2) and (3) 120 are based on the assumption that they are homogeneous over the membrane, i.e. an infinitely 121 long cylinder or full sphere is assumed. This assumption does not hold anymore when the bending 122 effects at the boundaries play a significant role for films with a relatively large thickness [8]. 123 Inhomogeneous fields are also expected in the case of buckled membranes, even for a very small 124 thickness, and in the pressure loaded case. This challenge is addressed by adopting a recently 125 developed Digital Height Correlation (DHC) based bulge test technique [8], to capture the non-126 uniform 3D displacement fields.

The fundamental concept underlying this extension is to apply digital image correlation on the topographical (height) maps of subsequent load increments (pressure increments), resulting in corresponding displacement fields. Curvature fields can subsequently be computed from the displacement fields. Based on the sample geometry, relations such as equation (2) can be used locally to obtain stress from curvature data, while the local strain can be obtained directly from the displacement fields. Therefore, the key assumption of a uniform cylindrical shape and uniform deformation adopted in the conventional bulge test methodology does not need to be fulfilled.Consequently, more accurate, local stress and strain fields can be obtained.

Digital Height Correlation is a variant of Global Digital Image Correlation (GDIC) and it is based on the conservation of height, instead of brightness, between a (topographical) reference image  $f(\vec{x})$  and a corresponding deformed image  $g(\vec{x})$ , where  $\vec{x}$  is the in-plane position vector, i.e.  $\vec{x} = x\vec{e}_x + y\vec{e}_y$ , with  $\vec{e}_x$  and  $\vec{e}_y$  denoting the Cartesian unit vectors. The conservation of height is written as:

$$f(\vec{x}) = g(\vec{x} + u_x(\vec{x})\vec{e}_x + u_y(\vec{x})\vec{e}_y) - u_z(\vec{x}),$$
(5)

140 where  $u_x$  and  $u_y$  are the in-plane displacement components in x and y direction respectively, 141 while  $u_z$  is the out-of-plane displacement component. The image residual  $r(\vec{x})$  is defined as:

$$r(\vec{x}) = f(\vec{x}) - g\left(\vec{x} + u_x(\vec{x})\vec{e}_x + u_y(\vec{x})\vec{e}_y\right) - u_z(\vec{x}) + n_0(\vec{x}),\tag{6}$$

$$\approx g(\vec{x}) + \left(\vec{\nabla}g \cdot \vec{e}_x\right)u_x(\vec{x}) + u_y(\vec{x}) + \left(\vec{\nabla}g \cdot \vec{e}_y\right)u_y(\vec{x}) - u_z(\vec{x}) + n_0(\vec{x}),\tag{7}$$

where  $n_0$  is the image noise and  $\vec{\nabla}g$  is the gradient of the deformed image g. The square of the image residual is minimized over the region of interest in the GDIC algorithm,

$$\gamma^2 = \int_{ROI} r(\vec{x})^2 d\vec{x},\tag{8}$$

144 where  $\gamma$  is the global residual. The 3D displacement vector is given by:

$$\vec{u}(\vec{x}) = u_x(\vec{x})\vec{e}_x + u_y(\vec{x})\vec{e}_y + u_z(\vec{x})\vec{e}_z.$$
(9)

To make this a well-posed optimization problem, the displacement field is parameterized as a sum of basis functions  $\varphi_i(\vec{x})$  that act over the ROI and weighted by a discrete set of degrees of 147 freedom  $\lambda_i$ . The choice of the basis and shape functions is based on the expected deformation 148 complexity. It should be noted that different shape functions may be required in the *x*, *y* and *z* 149 directions to capture the deformation. It has been shown that the shape of square and 150 rectangular bulged membranes are well described by polynomial functions [21].

$$\vec{u}(\vec{x}) = \sum_{i}^{l} \lambda_{i} \varphi_{i}(\vec{x}) \vec{e}_{x} + \sum_{i}^{m} \lambda_{i} \varphi_{i}(\vec{x}) \vec{e}_{y} + \sum_{i}^{n} \lambda_{i} \varphi_{i}(\vec{x}) \vec{e}_{z},$$
(10)

151 where the basis functions  $\varphi_i$  are chosen here to be polynomial functions, given by:

$$\varphi_i = x^{\alpha} y^{\beta} \tag{11}$$

Subsequently, the strain fields can be computed from the extracted displacement fields using an appropriate strain definition. To determine the relevant stress components, the curvature field is obtained with the same DHC measurement. The curvature tensor  $\kappa$  is determined by taking the spatial gradient of the outward normal vector  $\vec{n}$  field as:

$$\boldsymbol{\kappa}(\vec{x}) = \vec{\nabla} \otimes \vec{n}(\vec{x}), \tag{12}$$

where the outward normal vector is the normalized gradient of the position field  $z(\vec{x})$ , as given by:

$$\vec{n}(\vec{x}) = \frac{\vec{\nabla} z(\vec{x})}{||\vec{\nabla} z(\vec{x})||}.$$
(13)

158 The curvature fields in transverse direction is given by:

$$\kappa_{tt}(\vec{x}) = \vec{t}_x(\vec{x}) \cdot \boldsymbol{\kappa}(\vec{x}) \cdot \vec{t}_x(\vec{x}), \tag{14}$$

where  $\vec{t}_x$  is a vector tangent to the membrane surface along the *x* direction. These curvature fields will be used to determine the local stress components. For instance, for a local region with a plane strain state (in the middle of a non-buckled rectangular membrane), the curvature can be related to the hoop stress by:

$$\sigma_{tt} = \frac{P}{t\kappa_{tt}},\tag{15}$$

163 where *P* is the applied (uniform) pressure and *t* is the thickness of the membrane.

164

### 4 2.2 Experimental setup and procedure

165 A custom-made, gaseous pressure medium based bulge test setup (similar to the setup reported in Ref. [22]) is used (see Figure 3b) for the experiments. The setup consists of a sample holder 166 block attached to a pressurized N<sub>2</sub> reservoir through a pressure regulator. A commercially 167 168 available pressure regulator (MFCS-EZ by Fluigent) was used with a range of 0 - 200 kPa and a 169 resolution of 6 Pa (0.03% of full range). The pressure regulator and consequently the bulge test 170 setup has a fast response and settling time, which is an advantage over liquid based setups. While 171 liquid pressure-medium setups reach higher pressures, as needed for testing stiff (thick or narrow) films or plates, they can suffer adversely from pressure buildup problems in case of a 172 173 minute leakage or the presence of gas bubbles in the pressure medium. This is usually not a 174 problem in gaseous pressure-medium setups, since any drop in pressure due to leakages is 175 directly compensated through the connected large reservoir. Furthermore, the setup is less 176 sensitive to pressure changes due to ambient temperature variations compared to liquid based 177 setups.



179

Figure 3: Schematic of experimental setup for performing bulge test experiments: (a) high-resolution optical profilometry object, (b) bulge test setup, (c) pressure regulator to control pressure loading with regulator  $N_2$  supplied with through a cylinder reservoir, (d) magnified view of cross-section of a typical bulge sample with a thin film deposited in a silicon frame with an etched window in the center. The sample is fixed by gluing it onto the bulge tester sample holder.

The setup is placed under a commercially available optical profilometer, Sensofar Pl $\mu$  2300. The profilometer is used in confocal mode to obtain full-field topographical images. The highest magnification lens, with a magnification of 150x and Numerical Aperture (N.A.) of 0.95 is used to obtain high resolution images of the narrow ripples which are 20 – 30  $\mu m$  wide. The resulting field of view is 84x63  $\mu m^2$  with in-plane spatial sampling (pixel size) of 0.11  $\mu m$ , while the effective height resolution obtained is in the range of 25 nm. 192 Rectangular bulge test samples used for the proof of principle experiment were fabricated by 193 deposition of a (proprietary) multi-layered stack consisting of transition metals and oxides on a 194 monocrystalline 650  $\mu$ m thick silicon wafer. The freestanding window was created by wet etching from the back side of the wafer with a  $1x5 mm^2$  window. The sample has a total thickness of 195 196 64 nm and (volume averaged) Young's modulus (estimated by volume averaging using the rule 197 of mixtures) of 217 GPa and Poisson's ratio of 0.35. In general, application of DIC requires a good 198 pattern providing sufficient image contrast. In case of digital height correlation this contrast is 199 achieved by local differences in height on the sample surface. Since the native surface roughness 200 of the samples is in the order of a few nanometers, below the resolution of the profilometer, a 201 'height' pattern is applied. For this purpose, 500 nm mono-dispersed polystyrene microspheres 202 (by micromod<sup>®</sup>) were used. The microspheres were applied using the drop-casting method. The 203 particles are provided in a dense suspension and are further diluted (by a dilution factor of  $\sim 40$ ) 204 in ethanol to achieve the required particle density on the sample surface (see Figure 4). A 205 relatively dense pattern is required to capture the expected inhomogeneous displacement fields. 206 Since the particles do not form a continuous layer, adhering to the sample surface (upon contact, 207 without the need for an adhesive) as single particles or homogeneously distributed aggregates 208 composed of few particles, their influence on the mechanics of the membrane is assumed to be 209 negligible. Moreover, during the pressure loading step, the particles adhere well to the sample 210 and no pattern change or degradation is observed, which is important for reliable application of 211 DIC.



Figure 4: Images of ripples in a pressurized membrane with, optical image (left) and topographical image of an area imaged during the experiment, marked in the optical image by the red rectangle (right). The region of interest marked by the rectangle with black dashed lines is selected for DHC. The roughness pattern visible in the topographical image consists of clusters of 500 nm polystyrene microspheres, applied as a DHC pattern.

212

### 219 2.3 Numerical modelling

A non-linear FE model was set up to simulate the pressure loading of the test sample using the commercial FE program, MSC Marc/Mentat<sup>®</sup>. Since in the test specimens the meander profile starts transitioning to a ripple profile as soon as a slight pressure is applied [20] [see Figure 6], the analysis is focused on ripple and the cylindrical regime. As the substrate is many orders of magnitude stiffer than the film, it is modelled with rigid boundary conditions at the edges of the film. The rectangular membrane was meshed uniformly with quadrilateral 4-node thick-shell elements having three translational and three rotational degrees of freedom at each node. A mesh convergence study was performed and it was found that the solution becomes meshindependent at a size of 80×400 elements (used as the mesh size for the model).

229 Four batches of multi-layer test samples were available for testing, with varying material stack 230 thickness ratios and hence different overall membrane thickness and volume averaged Young's 231 modulus. The focus here is on developing a methodology for obtaining thickness-averaged 232 mechanical properties of the buckled membranes. This is also the case for conventional bulge test 233 which also provides thickness-averaged data only. Therefore, the Young's modulus and Poisson's 234 ratio in the FE model were set to 153.45 GPa and 0.351, respectively, based on a batch of 235 samples planned for fabrication but was never produced. Note, however, that the exact 236 properties used for the FE model are unimportant for the analysis and conclusion made and the 237 model serves as a general platform for virtual experiments. The dimensions of the membrane in 238 the FE model were taken as  $1 \times 5 mm^2$  in accordance with the size of the test samples, while the 239 membrane thickness was set to a value of 50 nm based on the median thickness batch.

To induce buckling in the membrane in-plane compressive load is required. The residual compressive stress was simulated through a thermal loading step resulting in an in-plane stress applied by the substrate (frame) on the freestanding membrane. This is caused by higher contraction of the substrate w.r.t the membrane on cooling down from a high temperature. Since the substrate was modelled by rigid membrane boundaries, the difference in coefficient of thermal expansion ( $\alpha$ ) of the substrate and the membrane ( $-2.6 \times 10 - 6 \circ C^{-1}$ ) was assigned to the membrane, to simulate this effect.

247



249 Figure 5: Three-step thermo-mechanical loading procedure for gradual onset of buckling, initially as a ripple 250 profile, finally settling into a meandering profile at the last load increment. In load step 1, the pressure is 251 increased while temperature is kept constant to result in an inflated cylindrical profile. Subsequently, in 252 load step 2, the temperature is decreased while the pressure is kept constant, resulting in thermal stresses 253 that (gradually) manifest themselves as increasing residual compressive stress while the pressure is 254 reduced (as the temperature is kept constant) in load step 3, triggering the onset of ripples. Note that the 255 top sub-figures represent membrane defection for the corresponding load increment with a line profile of 256 half of the longitudinal center line.

In order to avoid typical numerical instabilities at the bifurcation point (i.e. suddenly going from a flat to meandering shape in a single increment), a method used to model strongly buckled square membranes from Ref. [23] was adopted here. This involves bypassing the bifurcation point by adopting the three-step loading procedure illustrated in Figure 5. First the membrane is bulged 262 by application of a pressure load (Figure 6a<sub>3</sub>). Then, compressive residual stresses are induced in 263 the bulged membrane by applying the thermal loading step. In the final step the pressures is 264 gradually decreased to let the membrane slowly settle down into a rippled profile (Figure 6a<sub>2</sub>). If 265 the pressure is completely removed the membrane transitions from a rippled to a meandering 266 configuration (Figure 6a<sub>1</sub>). Using this method, in addition to bypassing the bifurcation point, the 267 strong and sudden geometrical nonlinearities expected at the transition from planar to 268 meandering configuration are avoided by gradually settling from the cylindrical to the rippled 269 configuration.

## 270 3. Numerical analysis

### 271 3.1 Simulation results

Using the three step loading procedure, explained in the previous section, the numerical model adequately captures the three different regimes seen in the experiments, i.e. the rippled, meandering regime, and the cylindrical regime. Moreover, the evolution of the rippled regime, with increasing pressure as well as the transitions between the different regimes seems are well captured. Comparison with experimentally observed regimes shown in Figure 6 provides a qualitative validation of the model.



Figure 6: Comparison between numerically modelled (a) and experimentally observed [24] (b) buckling regimes: meandering regime  $(a_1, b_1)$ , rippled regime  $(a_2, b_2)$  and cylindrical regime  $(a_3, b_3)$ , with membrane size 1x5 mm<sup>2</sup>(a) and 0.65x4.5 mm<sup>2</sup> (b). Note that similar buckling (meandering and rippled) regimes as in Ref. [24] are observed in our samples (see Figure 4), however, since cylindrical regime is not reached, the images are not shown here.

In order to also quantitatively validate the FE model, the Energy Minimization Method (EMM) based model reported by Kramer et al. ([24]) is exploited here. This model was developed to describe the rippled regime for a similar rectangular membrane with width *a* and thickness *h*, as discussed here. The model is able to predict the reduced ripple wavelength  $\overline{\lambda} = \frac{\lambda}{a}$ , the reduced peak-to-peak amplitude  $\Delta \overline{w} = \frac{\Delta w}{h}$  and the reduced ripple free amplitude  $\overline{w}_{ps} = \frac{w_{ps}}{h}$  (see Figure 7), as a function of the reduced prestrain  $\overline{\epsilon}_0 = \frac{\epsilon a^2}{h^2}$  and the reduced pressure  $\overline{p} = \frac{p(1-v^2)a^4}{Eh^4}$ .



Figure 7: Centre line profile of (half of) the membrane along the longitudinal direction, extracted from FE simulation at increasing pressure values loads, with the middle profile (in blue) corresponding to  $\bar{\epsilon}_0$ = -500 and  $\bar{p}$  = 7.48×10<sup>4</sup> displaying relevant parameters. The three profiles display the evolution of the buckling pattern with increasing pressure.

For realistic values of the applied pressure and residual stress (due to thermal loading) the results 299 300 for our test specimens lie significantly outside the boundaries of the plotted results presented in 301 Ref. [25], due to their very small thickness. In order to validate the FE model, smaller temperature-302 load and pressure values are applied to enable a comparison with the EMM results. Based on the 303 values of E, v and the coefficient of thermal expansion ( $\alpha$ ), used in the FE model, a temperature 304 difference of  $0.347 \,^{\circ}C$  and a pressure load of  $0.0818 \, Pa$  is calculated, which corresponds to a reduced strain,  $\bar{\epsilon}_{0test}$  of -500 and a reduced pressure  $\bar{p}_{test}$  of  $7.4811 \times 10^4$ , respectively, thus 305 306 bringing the  $\bar{e}_0$  and  $\bar{p}$  values within the bounds of the reported EMM results available (in Ref. 307 [25]). A line profile along the longitudinal axis in the middle of the membrane from the FE simulations is displayed in Figure 7 with the calculated reduced parameters which are given in 308

Table 1, along with the corresponding parameters from the EMM results at the same  $\bar{\epsilon}_0$  and  $\bar{p}$ values.

311

#### Table 1: Comparison of $\overline{\lambda}$ , $\overline{w}_{ps}$ and $\Delta \overline{w}$ predicted by EMM [25] and by the present FE analysis

	FE	ЕММ
$\bar{\lambda}$	$0.242\pm0.01$	0.250 ±0.005
$\overline{w}_{ps}$	20±0.4	19.7±0.2
$\Delta \overline{w}$	2.3±0.4	2.6±0.1

313

314

As can be seen in Table 1, the FE and EMM results agree for all three parameters within readout error from the FE and EMM results. However, the deviation for  $\Delta \overline{w}$  is significant. On the one hand, the higher variation for  $\Delta \overline{w}$  can partially be attributed to a higher readout error from the EMM plots, reflecting in the error bar in Table 1. On the other hand, the peak-to-peak amplitude varies over the length of the line profile in the FE results (see Figure 7), thus an average value of a relatively small magnitude is taken thereby, possibly contributing to the relatively high deviation. Based on the adequate agreement for all three values, FE model is considered valid.

# 322 **3.2** Numerical analysis of a suitable regions of interest:

As the model adequately captures the mechanics of the pressure loaded buckled membrane, it is well suited to be used as a numerical framework to test the methodology developed here, i.e. 325 serving as a virtual experiment. Various ROIs are analyzed, where, with suitable modifications,

326 bulge test analysis can be applied. The criteria for choosing a suitable ROI are:

327 1. The presence of a simplified stress or strain state, e.g. plane-strain

328 2. Membrane stresses can be conveniently calculated using an analytical equation, e.g. Eq. (2)

329 3. Membrane strains (using DHC) can be accurately determined

330 While the cylindrical regime may seem promising from the analysis point of view as classical 331 simple plane strain bulge equations may be applicable there, most initially-buckled membranes 332 (of various types) fracture before reaching the cylindrical regime, while those membranes that 333 can sustain a high enough pressure typically go into plasticity before entering the cylindrical 334 regime. Alternatively, the meandering regimes is not interesting form a practical point of view, as 335 it is only accessible at minute pressures [20]. Since the rippled regime exists throughout almost 336 the whole pressure loading cycle, only the rippled regime is here considered for further analysis. 337 Therefore, the analysis must be performed in the ripple regime.

338 There are multiple reason for choosing the ROI along the longitudinal center line of the 339 membrane. First, it is observed in the FE simulations and the experiments that the magnitude of 340 the ripples close to the longitudinal edge is lower than that of the same ripples in the center of 341 member, see Figure 8. This is due to the boundary constraints provided by the edge (on the edge 342 ripples can, of course, not form). Second, considering the third criterion of accurate 343 determination of the membrane strains using DHC keeping the ROI always in the field of view is 344 important. Due to symmetric deformation, an ROI in the center of the membrane experiences the 345 least rigid body motion, while closer to the membrane edge the large out of plane rotations result in large rigid body motion. Furthermore, these large out-of-plane rotations can affect the image residual, due to the change in effective viewing angle of the pattern, as discussed below. Finally, the boundary conditions at the edge are never as perfect as assumed in a Finite Elements simulation, especially when a dry etch is used to free the membrane, therefore, it is best to do the analysis far away from the edge, where these local boundary effects are negligible due to the well-known Saint-Venant's principle in solid mechanics. Therefore, the most suitable ROI is identified as an ROI along the longitudinal center line far away from the edges.



Figure 8: Comparison of simulated center line profile and edge line profile (calculated at the first free node
from the edge), at the first FEM increment that shows ripples (i.e. point 3 in Figure 5).

356

357 It can be assumed that the membrane is in a state of plane stress with respect to the thickness

direction, since the thickness of the membrane is very small relative to the other two dimensions

(with free contraction in the thickness direction). Indeed, the stress in the thickness direction due to the applied pressure is negligible compared to the in-plane stress. Furthermore, isotropic material behavior is assumed (which is common for thin films produced with thin film deposition techniques). Therefore, the isotropic linear elastic plane stress equations (Eq. (16) and (17)) apply for the present analysis.

$$\epsilon_{yy} = \frac{1}{E}\sigma_{yy} - \nu \frac{1}{E}\sigma_{xx},$$
(16)  

$$\epsilon_{xx} = -\nu \frac{1}{E}\sigma_{yy} + \frac{1}{E}\sigma_{xx},$$
(17)

364

where  $\epsilon_{yy}$  and  $\epsilon_{xx}$  are the normal membrane strains in the longitudinal and transverse direction, respectively, while,  $\sigma_{yy}$  and  $\sigma_{xx}$  are the membrane stresses in the longitudinal and transverse direction respectively.

The FE analysis shows that in the cylindrical regime the magnitude of the transverse stress  $\sigma_{xx}$  is 368 much larger than the longitudinal stress  $\sigma_{yy}$  as expected for a rectangular geometry. In the last 369 370 loading step, as the pressure is being reduced, at a certain stage (labelled point 3 in Figure 5), the 371 longitudinal stress becomes compressive while the transverse stress is still tensile. As soon as the 372 stress state in the longitudinal direction becomes compressive, the membrane releases the 373 compressive stress by buckling, in the form of a rippled pattern. Given its small thickness and 374 consequently negligible bending stiffness, the membrane does not possess the ability to support 375 a compressive stress, which is therefore released in a buckling pattern. This phenomenon is 376 illustrated in Figure 9. After the emergence of the ripples, as the pressure is further decreased, the longitudinal stress remains almost zero. The transverse stress however is still tensile and it keeps on decreasing with decreasing applied pressure. The small longitudinal stress varies over the width of a ripple due to the bending induced stress, and is therefore most compressive at the valley of the ripple while being least compressive at the peak of the ripple. At the crossover point in the middle of a ripple where the curvature is zero (marked with point C in Figure 11a) however, where bending effects do not contribute, the compressive stress is only due to the residual stress and ~300 times lower than  $\sigma_{xx}$  (at the ripple transition point), i.e. negligible.

384



385

Figure 9: Calculated transverse and longitudinal stress at the center in transverse direction and near the center in longitudinal direction, i.e. in the middle of a ripple where the curvature is zero, as a function of the applied pressure in the ripple and cylindrical regimes, revealing that the longitudinal stress stays close to zero in the rippled regime.

Accordingly, this configuration is close to uniaxial tension, i.e. there is only a non-zero stress in the transverse direction while the deformation in the longitudinal direction is governed by free contraction. Therefore Eq. (16) and (17) reduce to:

$$\epsilon_{yy} = -\nu \frac{1}{E} \sigma_{xx}.$$
(18)
$$\epsilon_{xx} = \frac{1}{E} \sigma_{xx}.$$
(19)

394 Inserting Eq. (19) into Eq. (18):

$$\epsilon_{yy} = -\nu \epsilon_{xx}.\tag{20}$$

Eq. (19) and (20) provide a direct (explicit) relationship between the relevant stress and strain components, which is linear, similar to the conventional plane strain bulge test. Furthermore, unlike the plane strain bulge test, where the Young's modulus and the Poisson's ratio are coupled in the plane strain modulus  $(\frac{E}{1-\nu^2})$ , here *E* and  $\nu$  can be obtained separately from a single experiment.

400 At this point it is important to note that in the regions where the ripples have locally diminished 401 along the longitudinal direction, e.g. point A in Figure 7, neither plane strain, nor plane stress 402 condition holds with respect to the in-plane directions due to which Eq. (16) and (17) cannot be 403 reduced to a simpler form to yield E and  $\nu$ , even in a coupled form. Therefore, the analysis is best 404 performed at the true center of the membrane (i.e. the middle in longitudinal direction), where 405 the ripples disappear for the highest pressure, making the above-mentioned analysis valid for the 406 largest pressure regime (another reason is that the rigid body motion is lowest at the true center 407 as discussed above).

408 The validity of the uniaxial tensile state (Eq. (19) and (20)) is assessed with a virtual experiment. 409 The stress and strain state is extracted from a node at the cross-over (zero curvature) point 410 (denoted as point C in Figure 11) in the ripple in the center of the membrane. The Young's 411 modulus is extracted from the gradient of the  $\sigma_{xx} - \epsilon_{xx}$  plot (see Figure 10a), whereas the 412 Poisson's ratio is extracted from the  $\epsilon_{yy} - \epsilon_{xx}$  plot (Figure 10b). The Young's modulus (with a value of 154.5 GPa) is extracted with an error of 0.68 %, while the resulting Poisson's ratio (with 413 a value of 0.357) reveals an error of 1.7 % with respect to the respective reference (input) values 414 in the FE model. 415

416



Figure 10: Stress and strain values extracted from FE results in the rippled regime to obtain Young's modulus (E) and Poisson's ratio (v): (a) Transverse stress ( $\sigma_{xx}$ ) vs. transverse strain ( $\epsilon_{xx}$ ) with a linear fit to provide E, and (b) Longitudinal strain ( $\epsilon_{yy}$ ) vs. transverse strain ( $\epsilon_{xx}$ ) with a linear fit to provide v.

422 Note that Eq. (15) is still valid in the rippled regime, allowing to relate the local curvature and 423 applied pressure to the transverse stress at the crossover point. This is the case, since at the 424 crossover point the local curvature in the longitudinal direction is almost zero, whereas  $\sigma_{vv}$  is negligible w.r.t  $\sigma_{xx}$  (as illustrated in Figure 9), thus the pressure applied to the face of the 425 426 membrane is entirely balanced by the transverse stress. The validity of Eq. (15) in the rippled regime is numerically assessed by computing the transverse stress  $\sigma_{xx}$  from  $\kappa_{tt}$  (extracted from 427 428 the FE simulation) and the applied pressure P (known in the simulation). The resulting value was 429 plotted against the transverse strain  $\epsilon_{xx}$  extracted from the FE simulation to determine the 430 Young's modulus, which has an error of 1.4 %.

431 Based on the relatively small errors in the extracted values, it is concluded that the proposed 432 method is promising. This analysis sets the basis of the characterization methodology. In a real 433 experiment,  $\sigma_{tt}$  can be determined using Eqs. (12) - (15) from the position field in the deformed configuration. While  $\epsilon_{yy}$  and  $\epsilon_{xx}$  can be obtained from the 3D displacement fields using Eqs. (26) 434 435 - (29), as will be shown in the next section. Furthermore, for the membranes that have not 436 ruptured before reaching the cylindrical regime at higher pressure, this method can be used in 437 conjunction with the plane strain equation. In that case, the same ROI analyzed in the rippled region can also be analyzed in the cylindrical plane strain state. 438

Practical application of DHC to the bulged buckled membranes requires highly accurate determination of 3D displacement fields as well as the position field in the reference configuration. This procedure is first tested in a virtual experiment. To this end, the displacement fields are extracted from the FE simulation in a typical ROI, from peak to valley in the longitudinal direction (marked in Figure 11a point A to B).



445

Figure 11: A schematic illustrating: top, middle and bottom layers of membrane long the longitudinal direction (a); and  $L_t^g$  and  $L_t^f$  used for determining the transverse membrane strain ( $\epsilon_{xx}$ ) (b); and longitudinal and transverse sections represented on FE simulation of rippled membrane (c).  $\Delta_x(\cdot)$  and  $\Delta_y(\cdot$ ) denote operators that act on the specified field to produce the field's finite difference in, respectively, the x- and y- direction.

These displacement fields and the resulting analysis correspond to the membrane mid-plane. In DHC however, only the membrane surface (top or bottom, see Figure 11a) can be analyzed and thus only displacements at the surface are determined. This causes a discrepancy of less than 0.5 % between the transverse displacements extracted from the mid-plane and the outer surface

456 (top/bottom) plane in the FE simulation. However, for the longitudinal displacement, due to the 457 significant curvature in that direction, the displacement at the surface is found to be considerably 458 different with respect to the displacement at the mid-plane. Nevertheless, the average of the 459 longitudinal strain over a full and half ripple width (as considered here), on the top surface should 460 be the same as on the mid-plane, since the difference in the length of a line profile from the peak 461 to the valley of the ripple in the top surface, middle and bottom planes (Figure 11a) will be 462 negligible, especially for small strains. This has been validated by the FE simulation. Therefore, 463 the average longitudinal strain over half the ripple width is computed, and plotted against the 464 transverse strain in Figure 13a, resulting in a value of Poisson's ratio with an error of only 0.3 %. 465 Another important observation can be made from Figure 12b, which shows that the longitudinal 466 displacement is in the order of a few nanometers. The best optical in-plane resolution is 467 approximately 250 nm. Even considering a subpixel resolution of ~0.01 pixels that can be 468 captured with DIC techniques, the longitudinal displacement cannot be captured accurately due 469 to the physical resolution limit. Furthermore it has been discussed in literature [26] that for large 470 out-of-plane rotations (high curvature changes), a systematic error in the displacement fields 471 might be introduced. To address this shortcoming, the longitudinal (in-plane) strain is disregarded 472 and only the rigid body motion in the longitudinal direction is used, together with the height 473 displacement field for determining the longitudinal membrane strain  $\epsilon_{\nu\nu}$ , see Figure 13b. The 474 resulting Poisson's ratio still has an error limited to 0.3%. Therefore, only the rigid-body motion 475 will be included as the displacement description in DHC to capture the longitudinal displacement 476 field.



Figure 12: Displacement fields and line-profiles extracted from FE simulations from peak to valley along the longitudinal axis in the rippled regime: (a) out-of-plane displacement field  $(u_z)$ , (b) longitudinal displacement field  $(u_y)$ , (c) transverse displacement field  $(u_x)$ , (d) mean-subtracted line-profiles of  $u_y$  and  $u_z$  at  $y = 33 \ \mu m$ .



Figure 13: Graphs of the longitudinal strain  $(\epsilon_{yy})$  as a function of the transverse strain  $(\epsilon_{xx})$  linear fits to extract the Poisson's ratio, where  $\epsilon_{yy}$  is averaged over a line-profile that ranges from ripple peak to valley, for **(a)**  $\epsilon_{yy}$  obtained from both  $\overline{u}_y$  and  $\overline{u}_z$  (from FE simulations) and **(b)**  $\epsilon_{yy}$  obtained only from  $\overline{u}_z$ .

488

# 489 4. Proof of principle experiment

Here, the results of a successful test serving as a proof of principle experiment to show the feasibility of application of the method in a real experiment are shown. Pressure increments of 2.5 kPa were applied to the sample and kept constant while the topographical images were acquired with the profilometer.

494 An ROI shown in Figure 4 from the peak to valley of a ripple is selected for DHC analysis. As 495 discussed in Ref. [8], a limited number of degrees of freedom (dofs) has to be used to capture the 496 deformation kinematics accurately. Too few dofs restrict the kinematics while too many can cause 497 the correlation to diverge while making it sensitive to image noise. Here, the expected order of 498 displacements is determined from the out-of-plane and transverse displacement fields extracted 499 from the FE simulations (Figure 12), defining the initial set of shape functions to be used for the 500 DHC analysis. More shape functions are subsequently added to optimize the correlation until the 501 residual fields cannot be further minimized. The longitudinal displacement only consists of a rigid-502 body term.

$$u_x = \lambda_1 x^0 y^0 + \lambda_2 x^0 y^1 + \lambda_3 x^1 y^0 + \lambda_4 x^1 y^1$$
(21)

$$u_y = \lambda_5 x^0 y^0 \tag{22}$$

$$u_{z} = \lambda_{6}x^{0}y^{0} + \lambda_{7}x^{0}y^{1} + \lambda_{8}x^{1}y^{0} + \lambda_{9}x^{1}y^{1} + \lambda_{10}x^{2}y^{0} + \lambda_{11}x^{2}y^{1} + \lambda_{12}x^{2}y^{2}$$
(23)  
+  $\lambda_{13}x^{0}y^{2} + \lambda_{14}x^{1}y^{2} + \lambda_{15}x^{1}y^{3} + \lambda_{16}x^{0}y^{3} + \lambda_{17}x^{0}y^{4} + \lambda_{18}x^{0}y^{5}$   
+  $\lambda_{19}x^{0}y^{6} + \lambda_{20}x^{0}y^{7} + \lambda_{21}x^{4}y^{3} + \lambda_{22}x^{1}y^{4} + \lambda_{23}x^{1}y^{5} + \lambda_{24}x^{1}y^{6}$   
+  $\lambda_{25}x^{1}y^{8} + \lambda_{26}x^{3}y^{8} + \lambda_{27}x^{5}y^{8} + \lambda_{28}x^{6}y^{8} + \lambda_{29}x^{2}y^{9}$ 

503 The number and order of shape functions needed to capture the out-of-plane displacement is 504 significantly higher than those required for the in-plane (transverse) displacement field, see 505 Eq.(21) and (23). This is expected since the predicted (from FE simulations) displacement field in 506 the height direction is considerably more complex than the in-plane (transverse) displacement 507 field, see Figure 12. This is not a problem since the optimization of the dofs related to out-of-508 plane shape functions is more robust than the in-plane shape functions, since the out-of-plane 509 displacement field directly affects the image residual, whereas, the in-plane displacement field affects the image residual through the (noisy) image gradient (see Eq. (7)). 510



Figure 14: Residual fields for selected region of interest: (a) before correlation, i.e.  $f(\vec{x}) - g(\vec{x})$  and (b) after correlation, i.e.  $f(\vec{x}) - g(\vec{x} + u_x(\vec{x}) + u_y(\vec{x})) + u_z(\vec{x})$ . Note the region in the black rectangle in (b), which contains an irreproducible feature, was masked from the correlation.



Figure 15: Displacement fields for selected region of interest obtained by DHC: **(a)** height displacement field ( $u_z$ ) and **(b)** transverse displacement field ( $u_x$ ).

516

521 The quality of the correlation in DHC is typically assessed by analyzing the residual fields. Figure 522 14a, and Figure 14b show the residual before and after correlation, respectively. The signature of 523 the pattern is vaguely visible after convergence, due to the increasing rotation of the membrane 524 during bulging, resulting in an altered viewing angle. However, the residual field has a very low 525 RMS value indicating that the correlation was successful. Moreover, a good qualitative agreement 526 can be seen between the shape of the displacement fields extracted from the simulations (Figure 527 12) and the displacement fields obtained from DHC analysis (Figure 15), confirming that the 528 deformation kinematics has been adequately captured.

Subsequently, the required membrane strain  $\epsilon_{xx}$  and  $\epsilon_{yy}$  are calculated from the obtained 3D displacement fields. This involves determination of strain with respect to a non-flat (rippled) initial configuration (*f*). The stretch ratios and principal logarithmic strains resulting from the deformation are given by:

$$\epsilon_{xx} = \ln(\lambda_t) \tag{24}$$

$$\epsilon_{yy} = \ln(\lambda_l) \tag{25}$$

533 where  $\lambda_t$  and  $\lambda_l$  are the stretch ratios ( $\lambda = \frac{current \, length}{original \, length}$ ) in the transverse and longitudinal

534 directions, respectively, and given by:

$$\lambda_{t} = \frac{L_{t}^{g}}{L_{t}^{f}}$$

$$\lambda_{l} = \frac{L_{l}^{g}}{L_{l}^{f}}$$
(26)
(27)

535  $L_t^g$  and  $L_t^f$  are denoted in Figure 11b and defined as:

$$L_t^g = \sqrt{\left(\Delta_x(x+u_x)\right)^2 + \left(\Delta_x(Z_f+u_z)\right)^2}$$
(28)

$$L_t^f = \sqrt{\left(\Delta_x(x)\right)^2 + \left(\Delta_x(Z_f)\right)^2}$$
(29)

where  $Z_f$  is the height map of the reference image (i.e.  $f(\vec{x})$ ), while  $\Delta_x(\cdot)$  denotes an operator 536 that acts on a field to produce the finite difference of the field in the x-direction. Since the 537 538 reference surface is expected to be non-smooth due to the applied pattern and its intrinsic surface roughness, the height map and resulting displacement fields will be non-smooth. A 539 540 surface polynomial fit of the reference image is used to smoothen this field. Similarly, for 541 determining the surface normal and curvature values using Eq. (13), a smoothed position field  $(Z_f + u_z)$  is adopted instead of the deformed configuration (topographical image)  $g(\vec{x})$ . 542 Likewise,  $L_l^g$  and  $L_l^f$  are given by: 543

$$L_l^g = \sqrt{\left(\Delta_y(y+u_y)\right)^2 + \left(\Delta_y(Z_f+u_z)\right)^2}$$
(30)

$$L_l^f = \sqrt{\left(\Delta_y(y)\right)^2 + \left(\Delta_y(Z_f)\right)^2}$$
(31)

where  $\Delta_{v}(\cdot)$  is the operator that produces the finite difference of the specified field in the y-544 545 direction. Subsequently the transverse stress is determined using Eqs. (12) - (15). The transverse stress  $\sigma_{xx}$  is plotted again the transverse strain  $\epsilon_{xx}$  in Figure 16a resulting in a Young's modulus 546 of 211  $\pm$  8 GPa. In order to obtain the Poisson's ratio, the mean longitudinal strain  $\bar{\epsilon}_{yy}$  (instead 547 of  $\epsilon_{ll}$ , as discussed in the previous section) is plotted against the transverse strain  $\epsilon_{xx}$  resulting in 548 549 a value of  $0.36 \pm 0.12$ . These values are in adequate agreement with the predicted (volume 550 averaged) Young's modulus and Poisson's ratio of respectively 217 GPa and 0.35, respectively. Therefore, the proposed methodology can be applied to obtain the elastic properties from a 551 552 buckled membrane.





Figure 16: Stress and strains obtained from DHC results plotted to determine Young's modulus *E* and Poisson's ratio v: (a) transverse stress ( $\sigma_{xx}$ ) vs. transverse strain ( $\epsilon_{xx}$ ) with a linear fit to obtain the Young's modulus (*E*) and (b) mean longitudinal strain ( $\bar{\epsilon}_{yy}$ ) vs. transverse strain ( $\epsilon_{xx}$ ) with a linear fit to obtain the Poisson's ratio (v).

559

# 560 5. Conclusions and Recommendations

1 It is well known from literature that conventional bulge testing, which is frequently used to characterize freestanding membranes, does not apply to the particular class of buckled membranes. In this paper, the conventional bulge test methodology has been extended to characterize the elastic properties of buckled membranes. This has been achieved by developing a validated FE based numerical model, which captures the complex mechanics of the (pressureloaded) buckled membrane. A recently developed DHC approach has been employed to obtain local, complex 3D displacement (strain) and curvature fields.

Interestingly, the virtual experiments revealed that, embedded in the seemingly complex ripple configuration, a simplified state of uniaxial stress exists in the transverse direction. This implies that the transverse stress can be directly related to the transverse strain, yielding Young's modulus. Poisson's ratio can be extracted directly from the ratio of the longitudinal strain and the transverse strain. This is a significant advantage over the conventional bulge test theory where Young's modulus and Poisson's ratio are intrinsically measured in a coupled manner, either through the plane strain modulus or the biaxial modulus. As a result, tests on two sample 575 geometries, typically rectangular and square shape, are needed to obtain Young's modulus and576 Poisson's ratio independently.

The numerical model also showed that applying DHC to measure the displacements in the longitudinal direction would require high-order shape functions and a displacement resolution that cannot be achieved with an optical system. This problem was solved by exploiting the fact that the contribution of the 'in-plane' longitudinal displacement to the longitudinal strain is negligible, allowing to obtain an accurate value of Poisson's ratio by only considering the height displacement to determine the longitudinal strain.

Proof of principle experiment clearly show that the method is applicable on real samples, even with rather narrow ripples dimensions (20-30  $\mu$ m) and only few data points, as the fragile samples were very susceptible to deformation induced failure. Residual maps indicate proper convergence and the shape of the displacement fields captured with DHC adequately match the predicted displacement fields extracted from the FE simulation, confirming that the buckled membrane kinematics are being properly captured. Moreover, the resulting values of Young's modulus and Poisson's ratio are consistent with the expected values based on the material stack.

As both the stress and strains are measured under uniaxial tension, the method is not necessarily confined to the elastic regime and should work as well in the plastic regime (yielding plasticity parameters), if the specimens would plastically deform. Furthermore, by applying cyclic pressure loading, fatigue testing, as suggested in Ref. [27] for plane strain loading, can be applied with uniaxial tension. Using a feedback loop to maintain a constant membrane stress, as suggested in Ref. [28], a creep test in uniaxial tension can be performed. 597 Acknowledgments

598 This work was supported by the Vidi funding of J.H. (project number 12966) within the 599 Netherlands Organization for Scientific Research (NWO). The authors would also like to greatly 600 thank Johan Klootwijk from Philips Research for proving the samples, Jan Neggers for sharing his 601 digital image correlation code, Roel Donders for upgrading the bulge test setup and help with 602 experiments and Marc van Maris for technical support in the laboratory.

603

### 604 **References**

605 [1] M.K. Small, W.D. Nix, Analysis of the accuracy of the bulge test in determining the

606 mechanical properties of thin films, J. Mater. Res. 7 (1992) 1553–1563.

- 607 doi:10.1557/JMR.1992.1553.
- J.J. Vlassak, W.D. Nix, A new bulge test technique for the determination of Young's
  modulus and Poisson's ratio of thin films, J. Mater. Res. 7 (1992) 3242–3249.
- 610 doi:10.1557/JMR.1992.3242.
- 611 [3] O. Tabata, K. Kawahata, S. Sugiyama, I. Igarashi, Mechanical property measurements of
- 612 thin films using load-deflection of composite rectangular membranes, Sensors and
- 613 Actuators. 20 (1989) 135–141. doi:10.1016/0250-6874(89)87111-2.
- 614 [4] J. Neggers, J.P.M. Hoefnagels, M.G.D. Geers, On the validity regime of the bulge

- 615 equations, J. Mater. Res. 27 (2012) 1245–1250. doi:10.1557/jmr.2012.69.
- 616 [5] H. Itozaki, Mechanical properties of composition modulated copper-palladium foils, Ph.D.
- 617 Thesis, University Northwestern, U.S.A., 1982.
- 618 [6] M.K. Small, J.J. Vlassak, W.D. Nix, Re-Examining the Bulge Test: Methods for Improving
- 619 Accuracy and Reliability, MRS Proc. 239 (1991) 257. doi:10.1557/PROC-239-257.
- 620 [7] Y. Xiang, X. Chen, J.J. Vlassak, Plane-strain Bulge Test for Thin Films, J. Mater. Res. 20
- 621 (2011) 2360–2370. doi:10.1557/jmr.2005.0313.
- 622 [8] J. Neggers, J.P.M. Hoefnagels, F. Hild, S. Roux, M.G.D. Geers, Direct Stress-Strain
- 623 Measurements from Bulged Membranes Using Topography Image Correlation, Exp.
- 624 Mech. 54 (2014) 717–727. doi:10.1007/s11340-013-9832-4.
- 625 [9] B. Wagner, H.J. Quenzer, S. Hoerschelmann, T. Lisec, M. Juerss, Bistable microvalve with
- 626 pneumatically coupled membranes, Proc. Ninth Int. Work. Micro Electromechanical Syst.
- 627 (1996) 384–388. doi:10.1109/MEMSYS.1996.494012.
- 628 [10] H. Mizoguchi, M. Ando, T. Mizuno, T. Takagi, N. Nakajima, Design and fabrication of light
  629 driven micropump, Proc. IEEE Micro Electro Mech. Syst. (1992) 31–36.
- 630 doi:10.1109/MEMSYS.1992.187686.
- 631 [11] S. Hirata, Y. Ishii, H. Matoba, T. Inui, An ink-jet head using diaphragm microactuator, Proc.
- 632 Ninth Int. Work. Micro Electromechanical Syst. (1996) 418–423.
- 633 doi:10.1109/MEMSYS.1996.494018.
- 634 [12] N. Yamamoto, D.J. Quinn, N. Wicks, J.L. Hertz, J. Cui, H.L. Tuller, B.L. Wardle, Nonlinear

636		regime, J. Micromechanics Microengineering. 20 (2010) 35027. doi:10.1088/0960-
637		1317/20/3/035027.
638	[13]	A. Evans, M. Prestat, R. Tölke, M.V.F. Schlupp, L.J. Gauckler, Y. Safa, T. Hocker, J. Courbat,
639		D. Briand, N.F. De Rooij, D. Courty, Residual stress and buckling patterns of free-standing
640		yttria-stabilized- zirconia membranes fabricated by pulsed laser deposition, Fuel Cells. 12
641		(2012) 614–623. doi:10.1002/fuce.201200028.

thermomechanical design of microfabricated thin plate devices in the post-buckling

- 642 [14] D. Beckel, A. Bieberle-Hütter, A. Harvey, A. Infortuna, U.P. Muecke, M. Prestat, J.L.M.
- Rupp, L.J. Gauckler, Thin films for micro solid oxide fuel cells, J. Power Sources. 173 (2007)
  325–345. doi:10.1016/j.jpowsour.2007.04.070.
- 645 [15] Y. Shi, A.H. Bork, S. Schweiger, J.L.M. Rupp, The effect of mechanical twisting on oxygen
- 646 ionic transport in solid-state energy conversion membranes, Nat Mater. 14 (2015) 721–
- 647 727. doi:10.1038/nmat4278.

- 648 [16] W. Bao, F. Miao, Z. Chen, H. Zhang, W. Jang, C. Dames, C.N. Lau, Controlled ripple
- texturing of suspended graphene and ultrathin graphite membranes., Nat. Nanotechnol.
  4 (2009) 562–6. doi:10.1038/nnano.2009.191.
- 651 [17] Y. Wang, R. Yang, Z. Shi, L. Zhang, D. Shi, E. Wang, G. Zhang, Super-elastic graphene
- ripples for flexible strain sensors, ACS Nano. 5 (2011) 3645–3650.
- 653 doi:10.1021/nn103523t.
- 654 [18] V.D. Camiola, R. Farchioni, T. Cavallucci, A. Rossi, V. Pellegrini, V. Tozzini, Hydrogen
- 655 Storage in Rippled Graphene: Perspectives from Multi-Scale Simulations, Front. Mater. 2

656 (2015) 2–4. doi:10.3389/fmats.2015.00003.

- 657 [19] E.W. Schweitzer, M. Göken, In situ bulge testing in an atomic force microscope:
- 658 Microdeformation experiments of thin film membranes, J. Mater. Res. 22 (2007) 2902–
- 659 2911. doi:10.1557/JMR.2007.0373.
- 660 [20] O. Paul, T. Kramer, Symmetry transitions of compressively prestressed long membranes
- 661 under pressure, in: TRANSDUCERS, Solid-State Sensors, Actuators Microsystems, 12th Int.
- 662 Conf. On, 2003, 2003: pp. 432–435 vol.1. doi:10.1109/SENSOR.2003.1215346.
- 663 [21] J. Neggers, J. Hoefnagels, F. Hild, S. Roux, M. Geers, Global Digital Image Correlation for
- 664 Pressure Deflected Membranes, in: G.A. Shaw, B.C. Prorok, L.A. Starman (Eds.), MEMS
- 665 Nanotechnology, Vol. 6 Proc. 2012 Annu. Conf. Exp. Appl. Mech., Springer New York, New

666 York, NY, 2013: pp. 135–140. doi:10.1007/978-1-4614-4436-7\_20.

- 667 [22] a. J. Kalkman, a. H. Verbruggen, G.C. a. M. Janssen, F.H. Groen, A novel bulge-testing
- setup for rectangular free-standing thin films, Rev. Sci. Instrum. 70 (1999) 4026.
- 669 doi:10.1063/1.1150029.
- 670 [23] V. Ziebart, O. Paul, H. Baltes, Strongly buckled square micromachined membranes, J.
  671 Microelectromechanical Syst. 8 (1999) 423–432. doi:10.1109/84.809057.
- 672 [24] V. Ziebart,k, (1999) 1–143.
- 673 [25] T. Kramer, O. Paul, Mechanical properties of compressively prestressed thin films
- 674 extracted from pressure dependent ripple profiles of long membranes, in: Micro Electro
- 675 Mech. Syst. 2003. MEMS-03 Kyoto. IEEE Sixt. Annu. Int. Conf., 2003: pp. 678–681.

676	[26]	J. Neggers, J.P.M. Hoefnagels, F. Hild, S. Roux, M.G.D. Geers, A global Digital Image
677		Correlation enhanced full-field bulge test method, Procedia IUTAM. 4 (2012) 73–81.
678		doi:10.1016/j.piutam.2012.05.022.

679 [27] B. Merle, M. Göken, Bulge fatigue testing of freestanding and supported gold films, J.

680 Mater. Res. 29 (2014) 267–276. doi:10.1557/jmr.2013.373.

- 681 [28] A.J. Kalkman, A.H. Verbruggen, G.C.A.M. Janssen, High-temperature bulge-test setup for
- 682 mechanical testing of free-standing thin films, Rev. Sci. Instrum. 74 (2003) 1383–1385.

683 doi:10.1063/1.1539901.